Search Notes

Application/Control No.	Applicant(s)/Patent Unde Reexamination
10613502	BEANE ET AL.

10613502	BEANE ET AL.
Examiner	Art Unit
Eric Blatt	3734

	SEARCHED		
Class	Subclass	Date	Examiner
606	144, 146	3-13-2008	EDB

SEARCH NOTES		
Search Notes	Date	Examiner
See attached EAST search history	3-13-2008	EDB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20080312